

UTT50N03L

Power MOSFET

50A, 30V N-CHANNEL
POWER MOSFET

■ DESCRIPTION

The UTC **UTT50N03L** is an N-channel power MOSFET using UTC's advanced technology to provide customers with a minimum on-state resistance and superior switching performance.

The UTC **UTT50N03L** is generally applied in low power switching mode power appliances and electronic ballast.

■ FEATURES

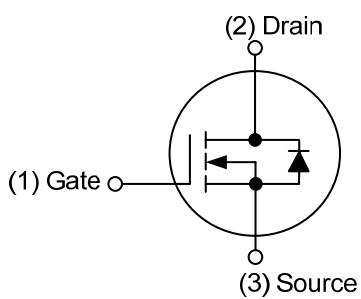
- * $R_{DS(ON)} \leq 7.8 \text{ m}\Omega$ @ $V_{GS}=10\text{V}$, $I_D=12\text{A}$

- $R_{DS(ON)} \leq 13 \text{ m}\Omega$ @ $V_{GS}=4.5\text{V}$, $I_D=9.0\text{A}$

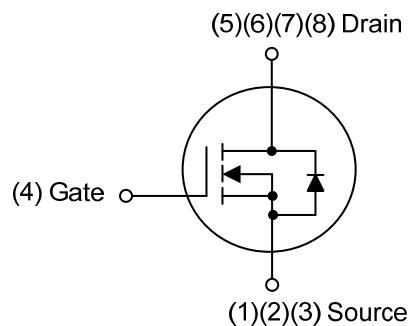
- * High Switching Speed

- * Improved dv/dt capability

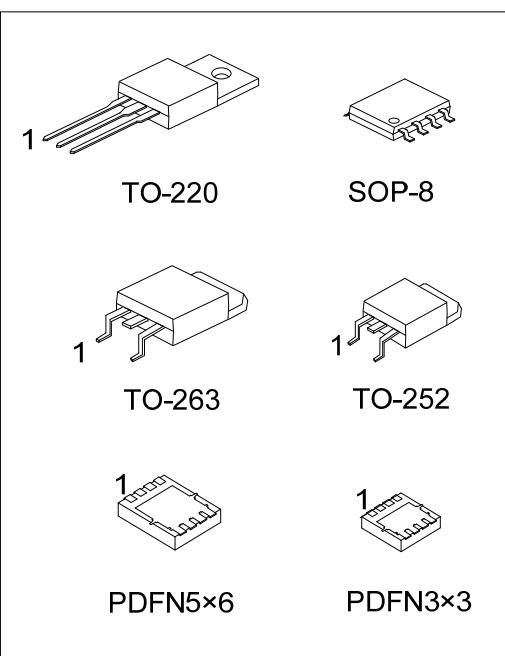
■ SYMBOL



TO-220 / TO-252 / TO-263



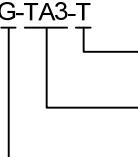
SOP-8 / PDFN3x3 / PDFN5x6



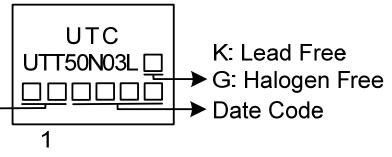
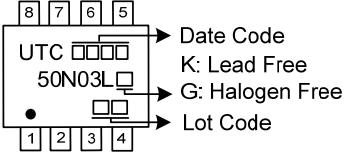
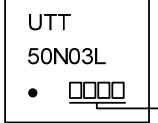
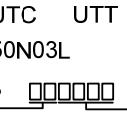
■ ORDERING INFORMATION

Ordering Number		Package	Pin Assignment								Packing
Lead Free	Halogen Free		1	2	3	4	5	6	7	8	
UTT50N03LK -TA3-T	UTT50N03LG-TA3-T	TO-220	G	D	S	-	-	-	-	-	Tube
UTT50N03LK-TN3-R	UTT50N03LG-TN3-R	TO-252	G	D	S	-	-	-	-	-	Tape Reel
UTT50N03LK -TQ2-T	UTT50N03LG -TQ2-T	TO-263	G	D	S	-	-	-	-	-	Tube
UTT50N03LK -TQ2-R	UTT50N03LG -TQ2-R	TO-263	G	D	S	-	-	-	-	-	Tape Reel
UTT50N03LK-S08-R	UTT50N03LG-S08-R	SOP-8	S	S	S	G	D	D	D	D	Tape Reel
UTT50N03LK-P3030-R	UTT50N03LG-P3030-R	PDFN3x3	S	S	S	G	D	D	D	D	Tape Reel
UTT50N03LK-P5060-R	UTT50N03LG-P5060-R	PDFN5x6	S	S	S	G	D	D	D	D	Tape Reel

Note: Pin Assignment: G: Gate D: Drain S: Source

 (1)Packing Type (2)Package Type (3)Green Package	(1) T: Tube, R: Tape Reel (2) TA3: TO-220, TN3: TO-252, TQ2: TO-263 S08: SOP-8, P3030: PDFN3x3, P5060: PDFN5x6 (3) G: Halogen Free and Lead Free, K: Lead Free
---	---

■ MARKING

TO-220 / TO-252 / TO-263	SOP-8
 Lot Code ← 1	 Date Code → K: Lead Free G: Halogen Free Lot Code → Date Code →
PDFN3x3	PDFN5x6
 Date Code →	 Lot Code ← → Date Code

■ ABSOLUTE MAXIMUM RATINGS ($T_c=25^\circ\text{C}$, unless otherwise specified)

PARAMETER	SYMBOL	RATINGS	UNIT
Drain-Source Voltage	V_{DSS}	30	V
Gate-Source Voltage	V_{GSS}	± 20	V
Continuous Drain Current	I_D	50	A
Pulsed Drain Current (Note 2)	I_{DM}	100	A
Avalanche Energy	Single Pulsed (Note 3)	E_{AS}	7.2 mJ
Peak Diode Recovery dv/dt		dv/dt	10 V/ns
Power Dissipation	TO-220/TO-263	P_D	62 W
	TO-252		42 W
	SOP-8		2.2 W
	PDFN3x3		25 W
	PDFN5x6		32 W
Junction Temperature	T_J	+150	$^\circ\text{C}$
Operation and Storage Temperature	T_{STG}	-55 ~ +150	$^\circ\text{C}$

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating: Pulse width limited by maximum junction temperature.

3. $L = 0.1\text{mH}$, $I_{AS} = 12\text{A}$, $V_{DD} = 25\text{V}$, $R_G = 20\Omega$, Starting $T_J = 25^\circ\text{C}$.

4. $I_{SD} \leq 30\text{A}$, $V_{DS}=0\text{V}$, $di/dt \leq 200\text{A}/\mu\text{s}$, $V_{DD} \leq BV_{DSS}$, Starting $T_J = 25^\circ\text{C}$.

■ THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT
Junction to Ambient	TO-220/TO-263	θ_{JA}	62.5 $^\circ\text{C/W}$
	TO-252		50 (Note) $^\circ\text{C/W}$
	SOP-8		125 (Note) $^\circ\text{C/W}$
	PDFN3x3		75 (Note) $^\circ\text{C/W}$
	PDFN5x6		65 (Note) $^\circ\text{C/W}$
Junction to Case	TO-220/TO-263	θ_{JC}	2 $^\circ\text{C/W}$
	TO-252		2.97 (Note) $^\circ\text{C/W}$
	SOP-8		56 (Note) $^\circ\text{C/W}$
	PDFN3x3		5 (Note) $^\circ\text{C/W}$
	PDFN5x6		3.9 (Note) $^\circ\text{C/W}$

Note: Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.

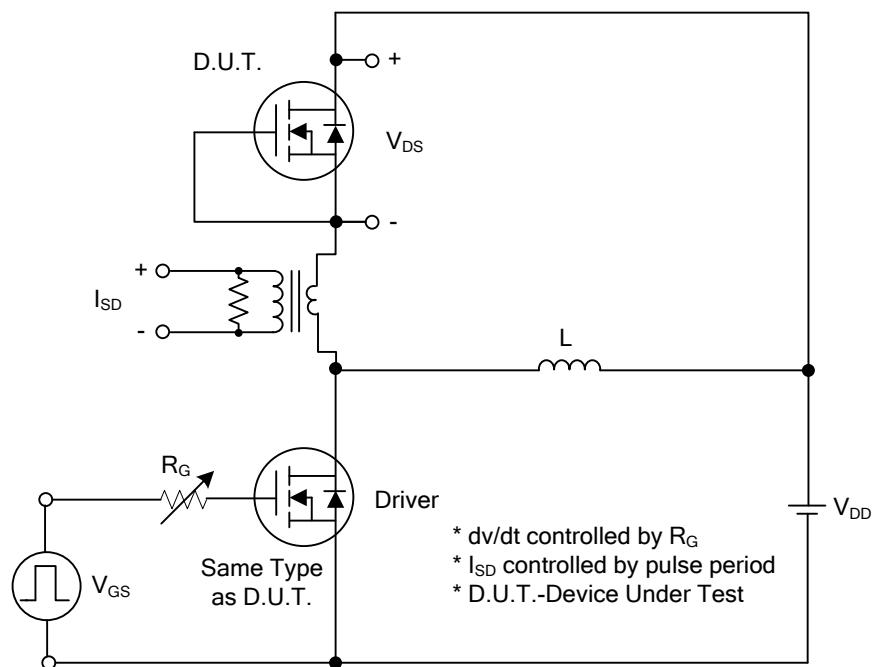
■ ELECTRICAL CHARACTERISTICS ($T_c=25^\circ\text{C}$, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	30			V
Drain-Source Leakage Current	I_{DSS}	$V_{\text{DS}}=30\text{V}, V_{\text{GS}}=0\text{V}$		1		μA
Gate-Source Leakage Current	Forward	$V_{\text{GS}}=20\text{V}, V_{\text{DS}}=0\text{V}$		100	nA	
	Reverse	$V_{\text{GS}}=-20\text{V}, V_{\text{DS}}=0\text{V}$		-100	nA	
ON CHARACTERISTICS						
Gate Threshold Voltage	$V_{\text{GS(TH)}}$	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=250\mu\text{A}$	1.0		3.0	V
Static Drain-Source On-State Resistance	$R_{\text{DS(ON)}}$	$V_{\text{GS}}=10\text{V}, I_{\text{D}}=12\text{A}$		5.8	7.8	$\text{m}\Omega$
		$V_{\text{GS}}=4.5\text{V}, I_{\text{D}}=9.0\text{A}$		9.0	13	$\text{m}\Omega$
DYNAMIC CHARACTERISTICS						
Input Capacitance	C_{iss}	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=15\text{V}, f=1\text{MHz}$		1280		pF
Output Capacitance	C_{oss}			270		pF
Reverse Transfer Capacitance	C_{rss}			229		pF
SWITCHING CHARACTERISTICS						
Total Gate Charge	Q_G	$V_{\text{DS}}=15\text{V}, V_{\text{GS}}=10\text{V}, I_{\text{D}}=50\text{A}$ (Note1,2)		44		nC
Gate-Source Charge	Q_{GS}			5		nC
Gate-Drain Charge	Q_{GD}			10.5		nC
Turn-On Delay Time	$t_{\text{D(ON)}}$	$V_{\text{DS}}=15\text{V}, V_{\text{GS}}=10\text{V}, I_{\text{D}}=50\text{A},$ $R_G=3.3\Omega$ (Note1,2)		7		ns
Turn-On Rise Time	t_R			17		ns
Turn-Off Delay Time	$t_{\text{D(OFF)}}$			33		ns
Turn-Off Fall Time	t_F			23		ns
DRAIN-SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATINGS						
Maximum Continuous Drain-Source Diode Forward Current	I_S				50	A
Maximum Pulsed Drain-Source Diode Forward Current	I_{SM}				100	A
Drain-Source Diode Forward Voltage	V_{SD}	$I_S=50\text{A}, V_{\text{GS}}=0\text{V}$			1.5	V
Body Diode Reverse Recovery Time	t_{rr}	$I_S=30\text{A}, V_{\text{GS}}=0\text{V},$ $dI_S/dt=100\text{A}/\mu\text{s}$		250		ns
Body Diode Reverse Recovery Charge	Q_{rr}			1200		nC

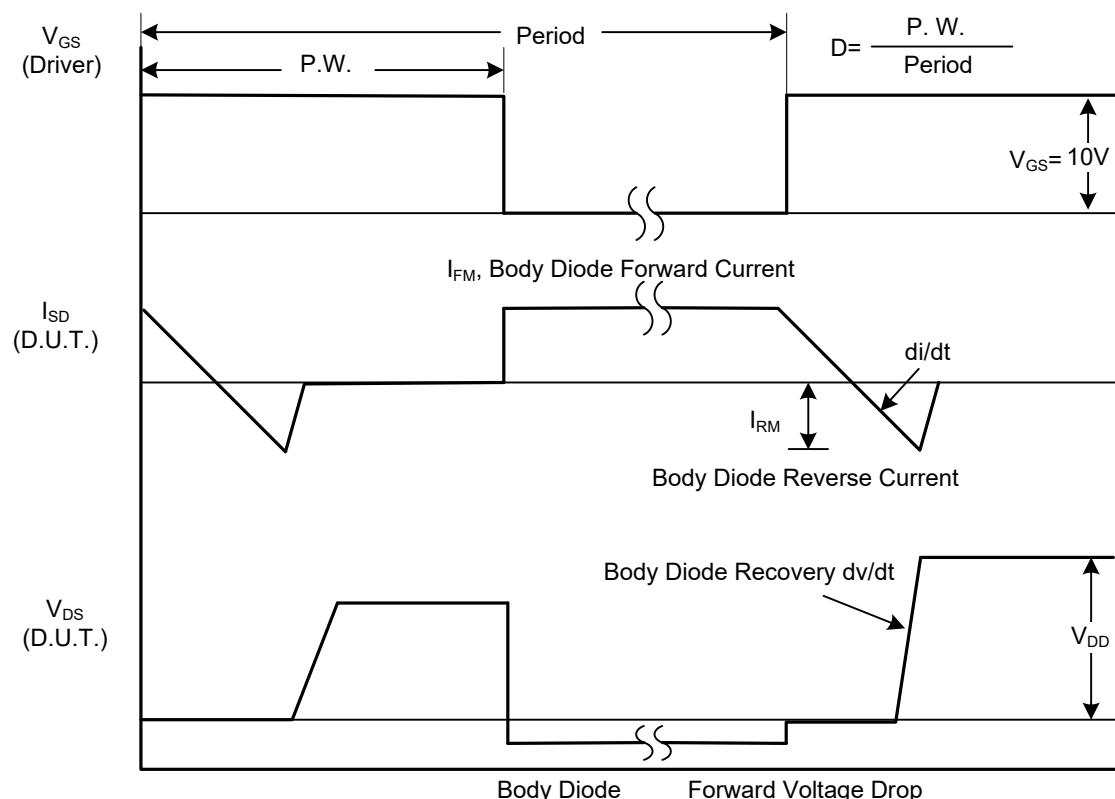
Notes: 1. Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$.

2. Essentially independent of operating temperature.

■ TEST CIRCUITS AND WAVEFORMS



Peak Diode Recovery dv/dt Test Circuit



Peak Diode Recovery dv/dt Waveforms

■ TEST CIRCUITS AND WAVEFORMS

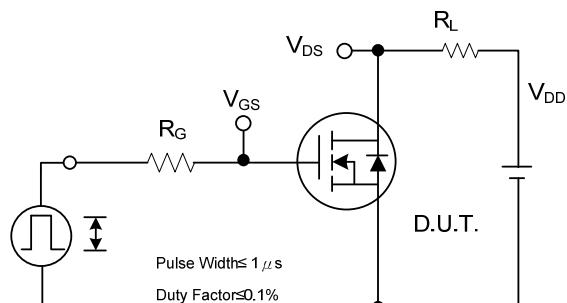


Fig. 2A Switching Test Circuit

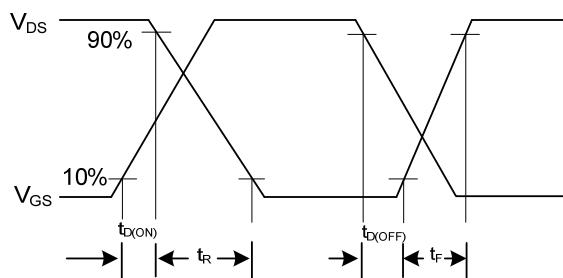


Fig. 2B Switching Waveforms

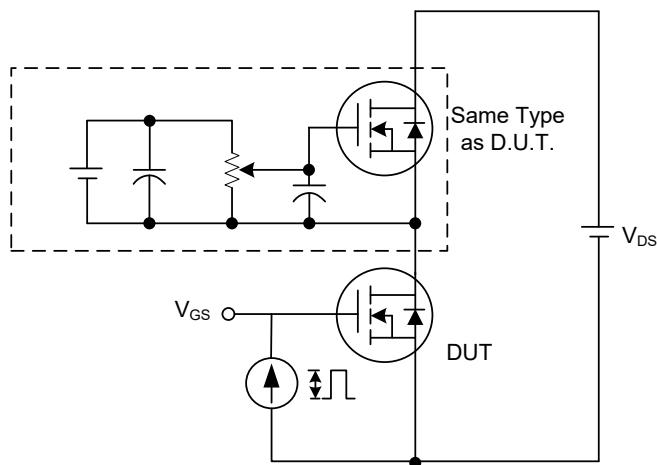


Fig. 3A Gate Charge Test Circuit

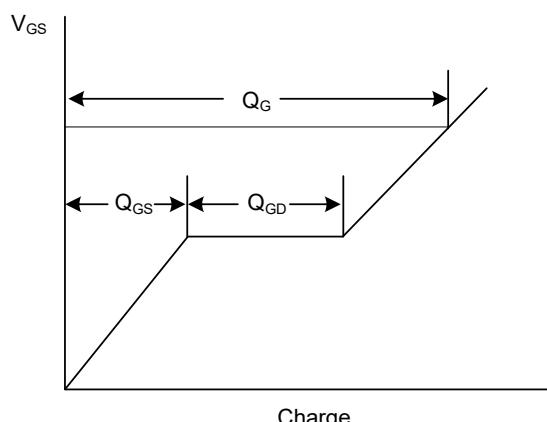


Fig. 3B Gate Charge Waveform

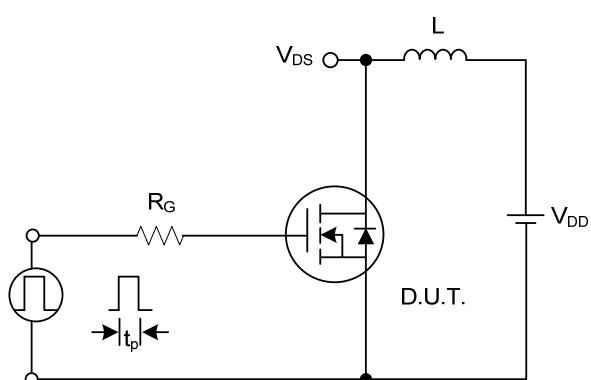


Fig. 4A Unclamped Inductive Switching Test Circuit

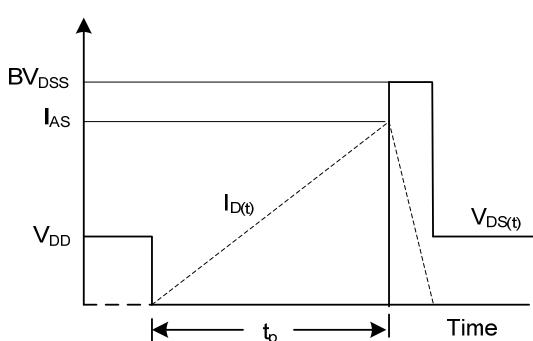
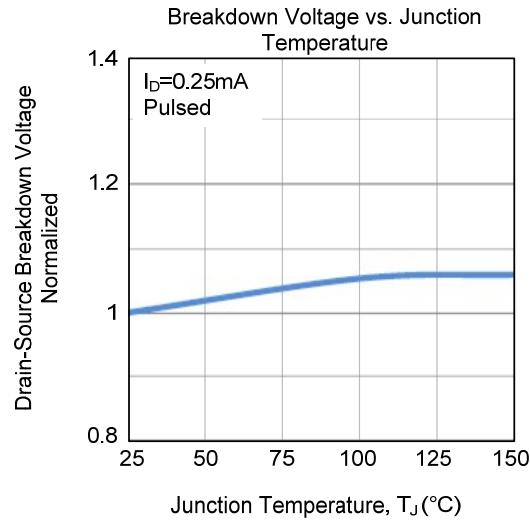
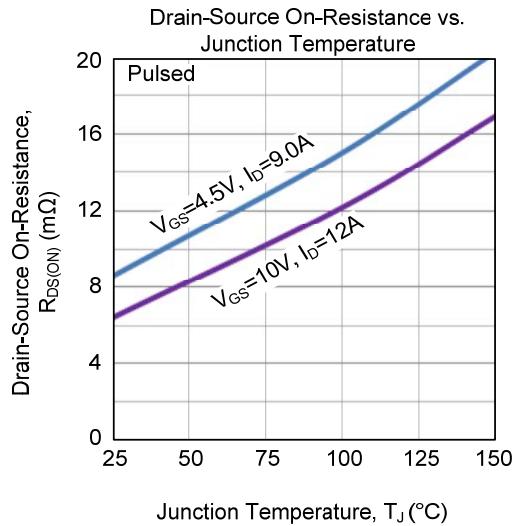
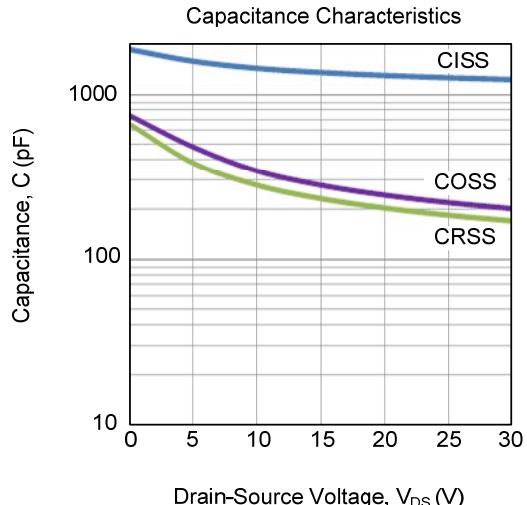
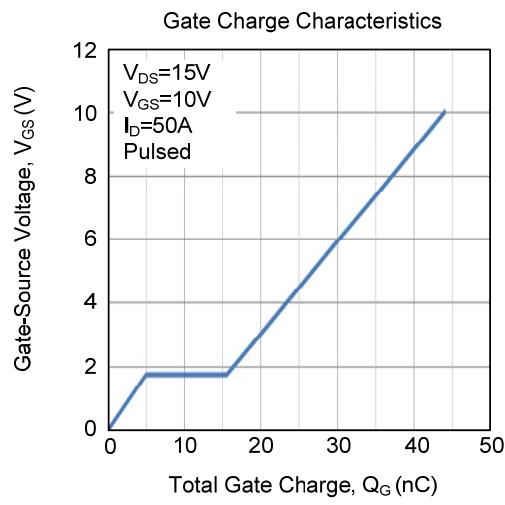
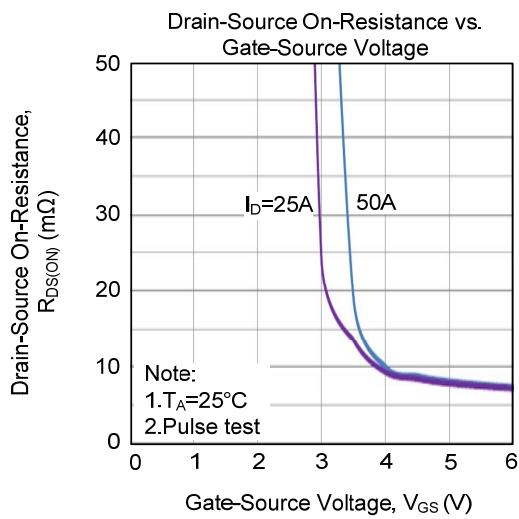
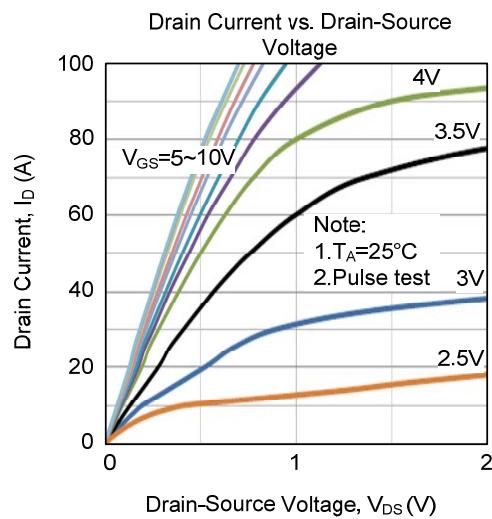
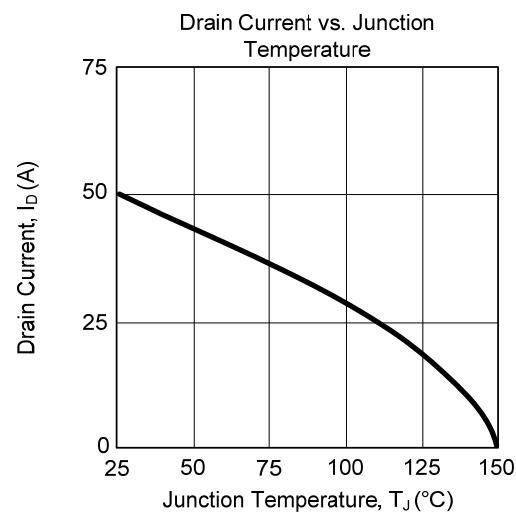
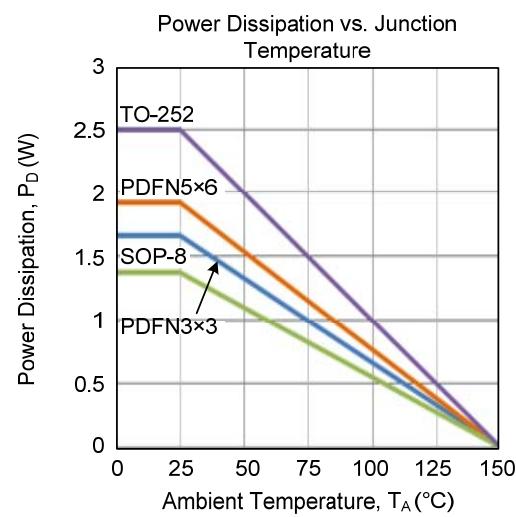
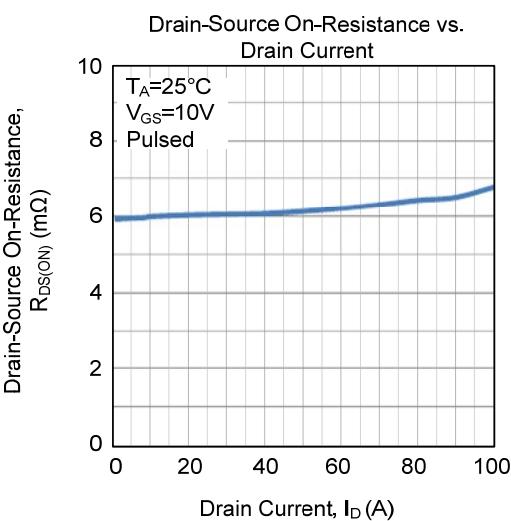
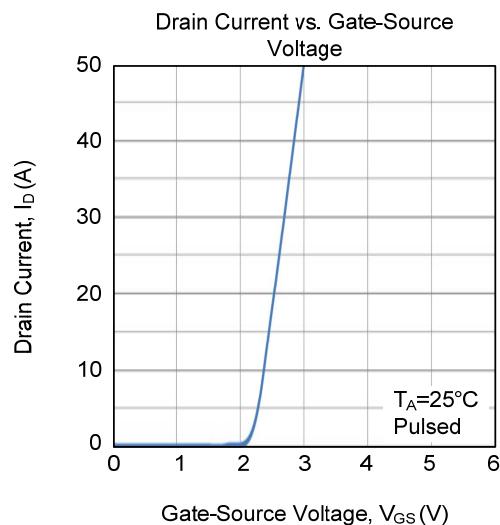
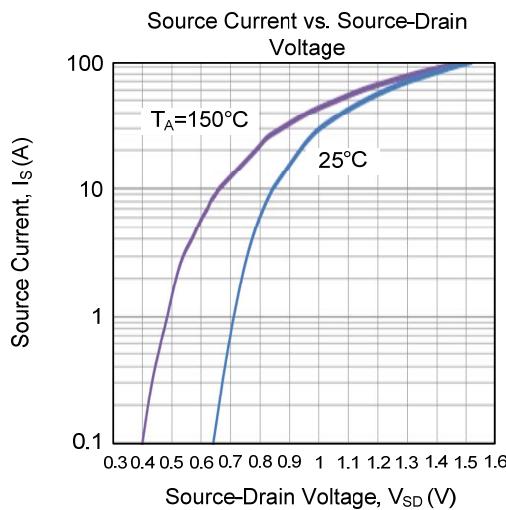
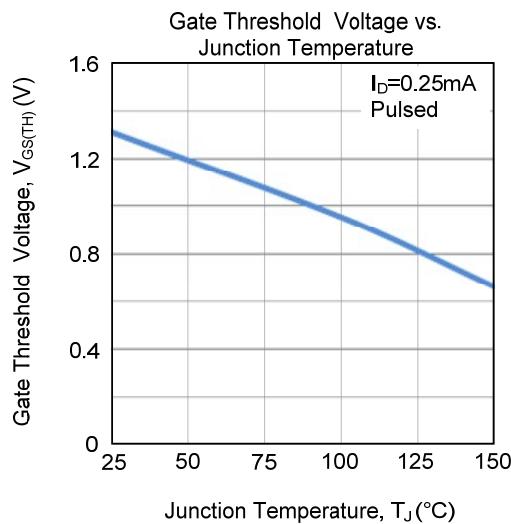


Fig. 4B Unclamped Inductive Switching Waveforms

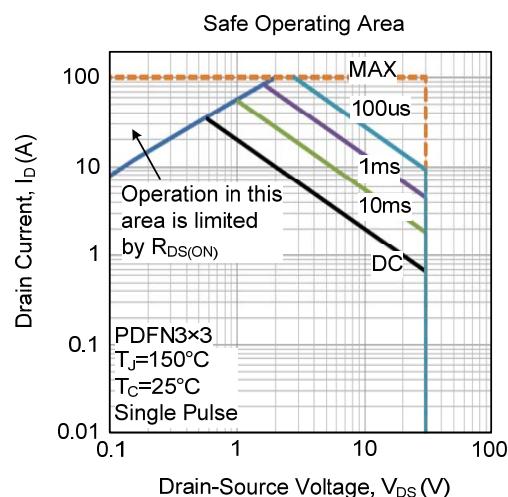
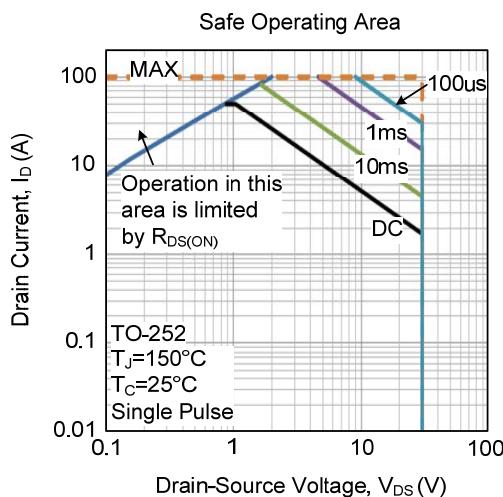
■ TYPICAL CHARACTERISTICS



■ TYPICAL CHARACTERISTICS (Cont.)



■ TYPICAL CHARACTERISTICS (Cont.)



UTC assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all UTC products described or contained herein. UTC products are not designed for use in life support appliances, devices or systems where malfunction of these products can be reasonably expected to result in personal injury. Reproduction in whole or in part is prohibited without the prior written consent of the copyright owner. UTC reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without notice. This document supersedes and replaces all information supplied prior to the publication hereof.